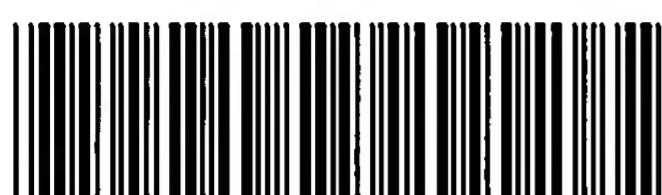


<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10601653	OHTSUKA, SHUICHI
	<b>Examiner</b>  Bayat, Ali	<b>Art Unit</b>  2624

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	115,218,219,224,229,181,170,190,198,305	1/18/07	A.B
348	231.2	1/18/07	A.B
358	450	1/18/07	A.B
	updated above	6/13/07	A.B
	updated above	11/19/07	A.B

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST ( US-PGPUB;USPA; EPO;JPO;DERWENT; IBM-TDB), and IEEE XPLORER, and Inventor name searched, see the search history print out.	1/18/07	A.B
updated above	6/13/07	A.B
updated above	11/19/07	A.B

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
US-PGPUB	USPGPUB SEE the text search history	1/20/07	A.B
	updated above	6/13/07	A.B
	updated above	11/19/07	A.B